

S1: (arrow mark) Rs > 99.9% @500-540nm + 1000-1070 nm Rp > 99.8% @507-527nm Rp > 99.9% @1005-1070nm |GDD(Rs)|<35fs² @500-540nm |GDD(Rp)|<50fs² @510-525nm |GDD(Rs)|<20fs² @1000-1070nm |GDD(Rp)|<40fs² @1010-1055nm
 S2: SCC coating for improved S1 flatness

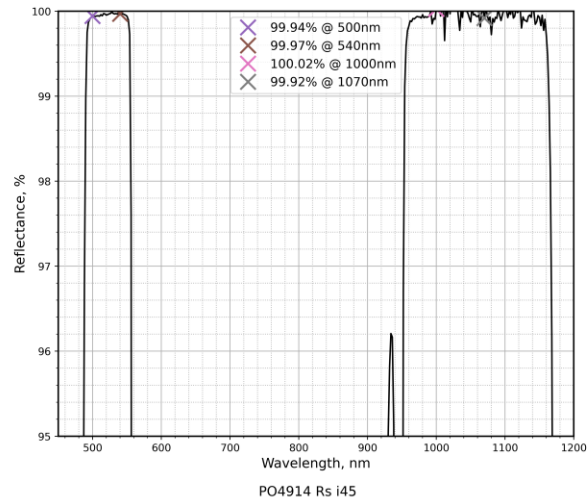


Fig. 1.

SIDE MEASURED: S1 (good component)

COMMENTS: Margin of measurement error: +/-0.25%

S1: (arrow mark) Rs > 99.9% @500-540nm + 1000-1070 nm Rp > 99.8% @507-527nm Rp > 99.9% @1005-1070nm |GDD(Rs)|<35fs² @500-540nm |GDD(Rp)|<50fs² @510-525nm |GDD(Rs)|<20fs² @1000-1070nm |GDD(Rp)|<40fs² @1010-1055nm
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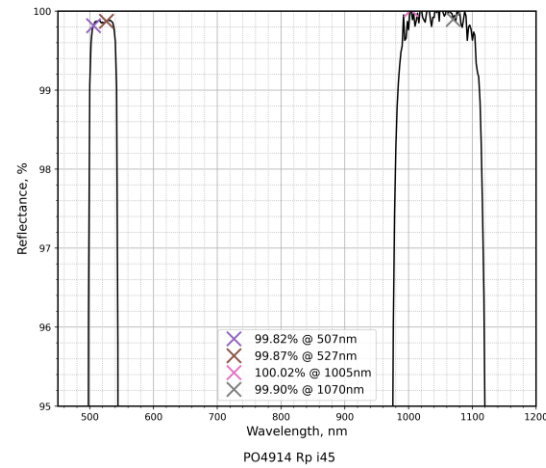


Fig. 2.

SIDE MEASURED: S1 (good component)

COMMENTS: Margin of measurement error: +/-0.25%